Power MOSFET

20 A, 30 V, N-Channel DPAK

This logic level vertical power MOSFET is a general purpose part that provides the "best of design" available today in a low cost power package. Avalanche energy issues make this part an ideal design in. The drain-to-source diode has a ideal fast but soft recovery.

Features

- Ultra-Low R_{DS(on)}, Single Base, Advanced Technology
- SPICE Parameters Available
- Diode is Characterized for use in Bridge Circuits
- I_{DSS} and V_{DS(on)} Specified at Elevated Temperatures
- High Avalanche Energy Specified
- ESD JEDAC rated HBM Class 1, MM Class A, CDM Class 0
- NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC–Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

- Power Supplies
- Inductive Loads
- PWM Motor Controls
- Replaces MTD20N03L in many Applications

MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V _{DSS}	30	Vdc
Drain-to-Gate Voltage (R_{GS} = 1.0 M Ω)	V _{DGR}	30	Vdc
Gate–to–Source Voltage – Continuous – Non–Repetitive (t _p ≤10 ms)	V _{GS} V _{GS}	±20 ±24	Vdc
$ \begin{array}{l} \text{Drain Current} \\ & -\text{ Continuous @ } T_{\text{A}} = 25^{\circ}\text{C} \\ & -\text{ Continuous @ } T_{\text{A}} = 100^{\circ}\text{C} \\ & -\text{ Single Pulse (} t_{p} \leq 10 \ \mu\text{s}) \end{array} $	I _D I _D I _{DM}	20 16 60	Adc Apk
Total Power Dissipation @ $T_A = 25^{\circ}C$ Derate above $25^{\circ}C$ Total Power Dissipation @ $T_C = 25^{\circ}C$ (Note 1)	P _D	74 0.6 1.75	W/°CW
Operating and Storage Temperature Range	T _J , T _{stg}	-55 to 150	°C
Single Pulse Drain–to–Source Avalanche Energy – Starting $T_J = 25^{\circ}C$ ($V_{DD} = 30 \text{ Vdc}, V_{GS} = 5 \text{ Vdc}, L = 1.0 \text{ mH},$ $I_{L(pk)} = 24 \text{ A}, V_{DS} = 34 \text{ Vdc}$)	E _{AS}	288	mJ
Thermal Resistance – Junction-to-Case – Junction-to-Ambient – Junction-to-Ambient (Note 1)	$f{R}_{ heta JC} \ f{R}_{ heta JA} \ f{R}_{ heta JA}$	1.67 100 71.4	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. When surface mounted to an FR4 board using the minimum recommended pad size and repetitive rating; pulse width limited by maximum junction temperature.



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20 A, 30 V, R_{DS(on)} = 27 mΩ









* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted)

Characteristic		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS				•		
Drain-to-Source Breakdown Voltage (Note 2) $(V_{GS} = 0 \text{ Vdc}, I_D = 250 \mu \text{Adc})$ Temperature Coefficient (Positive)		V _{(BR)DSS}	30 -	- 43	-	Vdc mV/°C
Zero Gate Voltage Drain Current $(V_{DS} = 30 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$ $(V_{DS} = 30 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_J = 150^{\circ}\text{C})$		I _{DSS}			10 100	μAdc
Gate-Body Leakage Current (VGS	$_{\rm S}=\pm20$ Vdc, V _{DS} = 0 Vdc)	I _{GSS}	-	-	±100	nAdc
ON CHARACTERISTICS (Note 2)						
Gate Threshold Voltage (Note 2) $(V_{DS} = V_{GS}, I_D = 250 \ \mu Adc)$ Threshold Temperature Coefficien		V _{GS(th)}	1.0 _	1.6 5.0	2.0 _	Vdc mV/°C
Static Drain-to-Source On-Resistance (Note 2) ($V_{GS} = 4.0 \text{ Vdc}, I_D = 10 \text{ Adc}$) ($V_{GS} = 5.0 \text{ Vdc}, I_D = 10 \text{ Adc}$)		R _{DS(on)}		28 23	31 27	mΩ
Static Drain-to-Source On-Voltage (Note 2) ($V_{GS} = 5.0 \text{ Vdc}, I_D = 20 \text{ Adc}$) ($V_{GS} = 5.0 \text{ Vdc}, I_D = 10 \text{ Adc}, T_J = 150^{\circ}\text{C}$)		V _{DS(on)}		0.48 0.40	0.54 -	Vdc
Forward Transconductance (Note 2) (V_{DS} = 5.0 Vdc, I_D = 10 Adc)		9fs	-	21	-	mhos
DYNAMIC CHARACTERISTICS						
Input Capacitance		C _{iss}	-	1005	1260	pF
Output Capacitance	(V _{DS} = 25 Vdc, V _{GS} = 0 Vdc, f = 1.0 MHz)	C _{oss}	-	271	420	
Transfer Capacitance	- /	C _{rss}	-	87	112	
SWITCHING CHARACTERISTICS	(Note 3)					
Turn–On Delay Time		t _{d(on)}	-	17	25	ns
Rise Time	$(V_{DD} = 20 \text{ Vdc}, I_D = 20 \text{ Adc}, V_{GS} = 5.0 \text{ Vdc},$	t _r	-	137	160	
Turn–Off Delay Time	$R_{G} = 9.1 \Omega$ (Note 2)	t _{d(off)}	-	38	45	
Fall Time		t _f	-	31	40	
Gate Charge		QT	-	13.8	18.9	nC
	(V _{DS} = 48 Vdc, I _D = 15 Adc, V _{GS} = 10 Vdc) (Note 2)	Q ₁	-	2.8	-	
		Q ₂	-	6.6	-	
SOURCE-DRAIN DIODE CHARAC	TERISTICS					
Forward On–Voltage	$(I_S = 20 \text{ Adc}, V_{GS} = 0 \text{ Vdc}) \text{ (Note 2)}$ $(I_S = 20 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 125^{\circ}\text{C})$	V _{SD}		1.0 0.9	1.15 -	Vdc
Reverse Recovery Time		t _{rr}	-	23	-	ns
	(I _S =15 Adc, V _{GS} = 0 Vdc,	ta	-	13	-	
	$dI_{S}/dt = 100 \text{ A}/\mu\text{s}$ (Note 2)	t _b	-	10	-	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Q_{RR}

0.017

uС

2. Pulse Test: Pulse Width \leq 300 µs, Duty Cycle \leq 2%.

3. Switching characteristics are independent of operating junction temperature.

ORDERING INFORMATION

Reverse Recovery Stored Charge

Device	Package	Shipping [†]
NTD20N03L27T4G	DPAK (Pb–Free)	2500 / Tape & Reel
NVD20N03L27T4G*	DPAK (Pb–Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

*NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC–Q101 Qualified and PPAP Capable.





vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current



PACKAGE DIMENSIONS

DPAK (SINGLE GAUGE) CASE 369C ISSUE E



NOTES

- 1. DIMENSIONING AND TOLERANCING PER ASME
- Y14.5M, 1994. 2. CONTROLLING DIMENSION: INCHES. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
- 4. DIMENSIONS DAND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL
- NOT EXCEED 0 006 INCHES PER SIDE 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM
- PLANE H.

OPTIC	OPTIONAL MOLD FEATURE.				
	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.028	0.045	0.72	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
E	0.250	0.265	6.35	6.73	
е	0.090 BSC		2.29 BSC		
н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.114	0.114 REF		REF	
L2	0.020) BSC 0.51 BS		BSC	
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		



STYLE 2: PIN 1. GATE 2. DRAIN

3. SOURCE

4. DRAIN

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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